

- L27 ANSWER 5 OF 25 HCAPLUS COPYRIGHT 2004 ACS on STN
 AN 1999:165487 HCAPLUS
 TI Low cost/high volume laser modules using silicon optical bench technology
 AU Osenbach, J. W.; Dautartas, M. F.; Pitman, E.; Nijander, C.; Brady, M.; Schlenker, R. K.; Butrie, T.; Scrak, S. P.; Auker, B. S.; Kern, D.; Salko, S.; Rinaudo, D.; Whitcraft, C.; Dormer, J. F.
 SO Proceedings - Electronic Components & Technology Conference (1998), 48th, 581-587
 CODEN: PETCES
 AB A review with 8 refs. As the information age continues to expand, there is a considerable need for low cost/ high volume, reliable **optoelectronic** modules. Because of the potential cost savings, Si optical bench technol. (SiOB) has emerged as one of the leading enabling technol. candidates needed for the com. realization of such modules. As a result, over the past 3 to 5 yr, there was a significant number of papers published on the use of SiOB for low cost **optoelectronic** modules. The authors report on the use of SiOB technol. used in the production of low cost/high volume, reliable laser modules. The SiOB platform is designed for manufacturability, reduced parts count, reduced process steps, and **ability** to accept design changes to respond to a rapidly changing marketplace. For example, this SiOB technol. was used for at least 4 different laser designs/types without significant changes in the SiOB manufacturing, optical subassembly, or package assembly process. The SiOB technol. is the 1st of its kind in that it integrates: (i) Si micromachining for the **lens** holder cavities and back face monitor turning mirror, (ii) Ti/Pt/Au for interconnect metalization and **photodiode bonding**, (iii) Al for AlO **bonding attachment** of the **lens**, and (iv) Au/Sn solder for laser **attachment**. The laser and **photodiode** are passively aligned using a visual alignment system and fiducials on the Si. The **lens** is self-aligned to the Si during the AlO **bonding** process. **Because the authors use AlO bonding for lens attachment and solder bonding for laser and photodiode attachment, this optical subassembly (OSA) contains no organic materials.** Following the discussion on the OSA assembly technol., the authors discuss the assembly technol. used to produce low cost uncooled laser modules and the performance of these modules. As was the case for OSA assembly, no organic **adhesives** are used in the hermetic enclosure of the laser module assembly. Finally, the authors present the reliability data for the module. The reliability data indicate that the optical alignment of these modules is extremely stable. The authors observe essentially no change in optical coupling as a result of extended storage at 85C, extended temperature cycling between -40C and +85C, or extended storage at 40C/95%RH. To knowledge, this is the 1st high volume/low cost, highly reliable edge emitting laser module that extensively uses SiOB technol. and design for manufacture principles.
- IT **Adhesives**
 Electronic packages
 Lenses
 Micromachining
 Optoelectronics
 Photodiodes
 Semiconductor lasers
 (low cost/high volume laser modules using silicon optical bench technol.)
- IT 7429-90-5, Aluminum, uses 7440-06-4, Platinum, uses **7440-21-3**, Silicon, uses **7440-31-5**, Tin, uses 7440-32-6, Titanium, uses 7440-57-5, Gold, uses
 RL: DEV (Device component use); USES (Uses)
 (low cost/high volume laser modules using silicon optical bench technol.)
- IT **7440-21-3**, Silicon, uses **7440-31-5**, Tin, uses
 RL: DEV (Device component use); USES (Uses)
 (low cost/high volume laser modules using silicon optical bench technol.)

(FILE 'REGISTRY' ENTERED AT 12:18:45 ON 11 MAR 2004)

L1 QUE A3/PG(L)A5/PG NOT (C OR H)/ELS
 L2 QUE (A1 OR A2 OR A4 OR A6 OR A7 OR A8)/PG
 L3 QUE (B3 OR B4 OR B5 OR B6 OR B7 OR B8 OR B1 OR B2)/PG
 L4 9931 SEA L1 NOT (L2 OR L3)
 L5 QUE B2/PG(L)A6/PG NOT (C OR H)/ELS
 L6 QUE (A1 OR A3 OR A4 OR A5 OR A7 OR A8)/PG
 L7 QUE (B3 OR B4 OR B5 OR B6 OR B7 OR B8 OR B1 OR B3)/PG
 L8 4251 SEA L5 NOT (L6 OR L7)
 L9 QUE (A4/PG OR C/ELS) NOT H/ELS
 L10 QUE (A1 OR A2 OR A3 OR A5 OR A6 OR A7 OR A8)/PG
 L11 QUE (B3 OR B4 OR B5 OR B6 OR B7 OR B8 OR B1 OR B3)/PG
 L12 11705 SEA L9 NOT (L10 OR L11)

FILE 'HOME' ENTERED AT 12:24:04 ON 11 MAR 2004

FILE 'HCAPLUS, INSPEC, WPIX' ENTERED AT 12:29:53 ON 11 MAR 2004

L13 3573837 SEA (EFFIC##### OR ABILIT### OR OPTIM?)
 L14 414679 SEA HEMI? OR FRENEL? OR FRESNEL? OR ELLIPSOID? OR LENS##
 L15 896027 SEA LED# OR L(W)E(W)D OR LIGHT(W) (EMITT? OR
 EMISSI?) OR LUMINES? OR EL OR ELD OR ELECTROLUMIN? OR
 ELECTROPHOSPHOR? OR PHOSPHORES? OR SUPERLUMIN? OR OPTOELECT?
 OR OPTO(W)ELECT? OR ELECTROOPTIC? OR PHOTODIODE? OR (PHOTO OR
 OPTIC OR OPTO) (W)DIODE
 L16 1535827 SEA ?GLASS? OR ?SILICATE? OR SAPPHIRE#
 L17 7004739 SEA BOND? OR GLUE? OR GLUING OR ADHE#####
 OR ATTACH? OR FASTEN? OR AFFIX? OR CONNECT? OR JOIN? OR LINK?

FILE 'HOME' ENTERED AT 12:33:22 ON 11 MAR 2004

FILE 'HCAPLUS, INSPEC, WPIX' ENTERED AT 12:36:43 ON 11 MAR 2004

L18 323500 SEA (H01L051? OR H01L033? OR H05B033 OR
 G02F001? OR G09F009? OR H01S003?)/IC
 L19 1143320 SEA L18 OR L15

FILE 'HCAPLUS' ENTERED AT 12:38:39 ON 11 MAR 2004

L20 QUE L4 OR L8 OR L12
 L21 175 SEA (L20 OR L16)AND L13 AND L14 AND L17
 L22 31 SEA L21 AND L15
 L23 8 SEA L21 AND L18
 L24 34 SEA (L22 OR L23)
 L25 21 SEA L24 NOT P/DT NOT PY>2000
 L26 4 SEA L24 AND P/DT NOT PRD>20000912
 L27 25 SEA (L25 OR L26)

L27 ANSWER 9 OF 25 HCAPLUS COPYRIGHT 2004 ACS on STN
 AN 1998:53064 HCAPLUS
 TI Prospects of highly **efficient** AlGaInP based surface emitting type ring-**LED** for 50 and 156 Mb/s POF data **link** systems
 AU Dutta, Achyut Kumar
 SO Journal of Lightwave Technology (1998), 16(1), 106-113
 CODEN: JLTEDG; ISSN: 0733-8724
 AB The detail design and performance of the surface emitting type visible **light emitting diode (LED)** is described for using in the plastic optical fiber (POF)-based data **links**. The diode showed brightness ≤ 3.5 mW @ 100 mA (d.c.) and also exhibited the beam divergence angle $\geq 10^\circ$ with using of well designed plastic **lens**. The using of **LED** with plastic **lens** helps to attain also the coupling **efficiency** over 70% with POF. The temperature rise of the ring **LED** under operation also is 9 and 6° less than the conventional diode at 50 and 35 mA bias currents, resp. Transmission expts. reveal that the diode is suitable for 50 and 156 Mb/s 100 m POF-based data **links**.
 IT **Electroluminescent** devices
 (surface emitting; prospects of highly **efficient** AlGaInP based surface emitting type ring-**LED** for POF data **link** systems)
 IT 1303-00-0, Gallium arsenide, uses 37382-15-3, Aluminum gallium arsenide ((Al,Ga)As) 163207-18-9, Aluminum gallium indium phosphide
 RL: DEV (Device component use); USES (Uses)
 (prospects of highly **efficient** AlGaInP based surface emitting type ring-**LED** for POF data **link** systems)
 IT 1303-00-0, Gallium arsenide, uses 37382-15-3, Aluminum gallium arsenide ((Al,Ga)As) 163207-18-9, Aluminum gallium indium phosphide
 RL: DEV (Device component use); USES (Uses)
 (prospects of highly **efficient** AlGaInP based surface emitting type ring-**LED** for POF data **link** systems)
 RN 37382-15-3 HCAPLUS
 CN Aluminum gallium arsenide ((Al,Ga)As) (9CI) (CA INDEX NAME)

Component	Ratio	Component Registry Number
Ga	0 - 1	7440-55-3
As	1	7440-38-2
Al	0 - 1	7429-90-5

RN 163207-18-9 HCAPLUS
 CN Aluminum gallium indium phosphide (9CI) (CA INDEX NAME)

Component	Ratio	Component Registry Number
P	x	7723-14-0
In	x	7440-74-6
Ga	x	7440-55-3
Al	x	7429-90-5

L27 ANSWER 12 OF 25 HCAPLUS COPYRIGHT 2004 ACS on STN
AN 1997:314037 HCAPLUS
TI Wideband four channel optical transmitter package using vertical cavity
surface emitting laser arrays
AU Corazza, D. J.; Rajkumar, N.; Keyworth, B. P.; McMullin, J. N.; Macdonald, R. I.
SO Proceedings of SPIE-The International Society for Optical Engineering
(1997), 3005(Optoelectronic Interconnects and Packaging IV), 354-359
CODEN: PSISDG; ISSN: 0277-786X
AB The authors report on the fabrication of a prototype multichannel optical
transmitter based on vertical-cavity surface-emitting lasers (VCSELs). The
package consists of an array of 4 VCSELs, mounted directly on a RF circuit board,
and UV-curable polymer microlenses and waveguides which couple the laser output
to a multimode fiber ribbon. Light from the lasers is captured by refractive
polymer microlenses positioned on a **glass** substrate above the VCSEL array. The
lenses focus the light signals onto angled reflective end facets in the polymer
waveguides. These waveguides are situated on a sep. **glass** substrate which is
bonded to the **lens** substrate. The light is then coupled from the waveguides to a
multimode fiber ribbon; the average measured coupling **efficiency** was $47.5\% \pm 3\%$.
Exptl. measurements reveal an analog bandwidth of 2.65 GHz per channel with
better than 30 dB (elec.) isolation between adjacent channels for frequencies up
to 2 GHz without active heatsinking. It was exptl. verified that this isolation
is limited by the parasitics inherent in the VCSEL array rather than the
parasitics of the device driver circuitry.
IT **Electrooptical instruments**
Lenses
Optical waveguides
(wideband four channel optical transmitter package using vertical
cavity surface emitting laser arrays)
IT 7440-57-5, Gold, uses **24304-00-5**, Aluminum nitride
RL: DEV (Device component use); USES (Uses)
(wideband four channel optical transmitter package using vertical
cavity surface emitting laser arrays)
IT **24304-00-5**, Aluminum nitride
RL: DEV (Device component use); USES (Uses)
(wideband four channel optical transmitter package using vertical
cavity surface emitting laser arrays)

L27 ANSWER 16 OF 25 HCAPLUS COPYRIGHT 2004 ACS on STN

AN 1992:642441 HCAPLUS

TI High radiance indium gallium arsenide phosphide/indium phosphide **lensed LEDs** for optical communication systems at 1.3 μm

AU Hwang, C. K.; Wang, T. S.; Sung, C. P.; Hsu, S. H.; Chi, G. C.

SO MRL Bulletin of Research and Development (1992), 6(1), 45-8

CODEN: MBRDEZ; ISSN: 1010-2744

AB This study investigated the fabrication of high-radiance, InGaAsP/InP double heterostructure (DH) **light-emitting** diodes (**LEDs**) at 1.3 μm wavelength. The **LEDs**, with a small surface **light-emitting** region, are formed by alloying a metal film through a SiO₂ insulating layer contact to the semiconductor surface. The **LEDs** with dielec.-isolation show good I-V characteristics and less leakage current than those with a Schottky barrier. A typical light output of 1 mW was obtained at 100 mA. A spherical microlens is **attached** to the InP substrate to improve the coupling **efficiency**. The peak coupled power of .apprx.40 μW was achieved at 100 mA for a 62.5 μm core multimode fiber.

IT **Electroluminescent** devices

(indium gallium arsenide phosphide/indium phosphide, **lensed**,
for optical communication)

IT **22398-80-7**, Indium phosphide, uses

RL: USES (Uses)

(**LEDs** from gallium indium arsenide phosphide and,
lensed, high radiance, for optical communication)

IT **12645-36-2**, Gallium indium arsenide phosphide

RL: USES (Uses)

(**LEDs** from indium phosphide and, **lensed**, high
radiance, for optical communication)

IT **22398-80-7**, Indium phosphide, uses

RL: USES (Uses)

(**LEDs** from gallium indium arsenide phosphide and,
lensed, high radiance, for optical communication)

IT **12645-36-2**, Gallium indium arsenide phosphide

RL: USES (Uses)

(**LEDs** from indium phosphide and, **lensed**, high
radiance, for optical communication)

RN 12645-36-2 HCAPLUS

CN Gallium indium arsenide phosphide ((Ga,In)(As,P)) (9CI) (CA INDEX NAME)

Component	Ratio	Component Registry Number
P	0 - 1	7723-14-0
In	0 - 1	7440-74-6
Ga	0 - 1	7440-55-3
As	0 - 1	7440-38-2

L27 ANSWER 17 OF 25 HCAPLUS COPYRIGHT 2004 ACS on STN

AN 1987:25551 HCAPLUS

TI Package for **light-emitting** devices

IN Miyake, Yoshio; Myake, Yoshio; Takei, Toshio

PA Mitsubishi Electric Corp., Japan

	PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
PI	JP 61145876	A2	19860703	JP 1984-267384	19841220
PRAI	JP 1984-267384		19841220		

AB In a package using a vessel consisting of a header and a cap for housing a **light-emitting** device and a **lens** for focusing the emitted light in a cap hole, a parallel plate is fixed to the cap between the **lens** and the **light-emitting** device, which may be a **LED**. A convex **lens** having a flat side facing the **light-emitting** device may be fixed in the cap hole. The **lens** and/or the parallel plate may be made of Si, GaAs, CdTe, ZnSe, KRS5, As2S3, or AgCl. Optionally, a **lens** which may be spherical is fixed in a disk in front of the cap. The package maintains a high **connection efficiency** with optical fibers by using a parallel plate from a high-n material. Thus, a claimed material transparent to light 1.2-1.5 μm in wavelength from a **light-emitting** device was used for the parallel plate, together with a Si **lens**.

IC ICM H01L033-00

IT **Electroluminescent** devices

(high-refractive-index **lenses** and optical parallel plates
for)

IT **Lenses**

(high-refractive-index, for **light-emitting**-device
packages)

IT 1303-00-0, Gallium arsenide, uses and miscellaneous 1303-33-9
1306-25-8, uses and miscellaneous 1314-98-3, uses and
miscellaneous 1315-09-9 7440-21-3, uses and
miscellaneous 7783-90-6, uses and miscellaneous 76363-73-0, KRS5
RL: USES (Uses)

(**lenses** and parallel plates from, in **light-**
emitting device packages)

IT 1303-00-0, Gallium arsenide, uses and miscellaneous
1306-25-8, uses and miscellaneous 1314-98-3, uses and
miscellaneous 1315-09-9 7440-21-3, uses and
miscellaneous
RL: USES (Uses)

(**lenses** and parallel plates from, in **light-**
emitting device packages)

RN 1303-00-0 HCAPLUS

CN Gallium arsenide (GaAs) (8CI, 9CI) (CA INDEX NAME)

RN 1306-25-8 HCAPLUS

CN Cadmium telluride (CdTe) (9CI) (CA INDEX NAME)

RN 1314-98-3 HCAPLUS

CN Zinc sulfide (ZnS) (9CI) (CA INDEX NAME)

RN 1315-09-9 HCAPLUS

CN Zinc selenide (ZnSe) (9CI) (CA INDEX NAME)

RN 7440-21-3 HCAPLUS

CN Silicon (7CI, 8CI, 9CI) (CA INDEX NAME)

L27 ANSWER 18 OF 25 HCAPLUS COPYRIGHT 2004 ACS on STN

AN 1984:414863 HCAPLUS Full-text

DN 101:14863

TI Gallium indium arsenide phosphide/indium phosphide **LED** with improved productivity and output characteristics

PA Toshiba Corp., Japan

SO Jpn. Kokai Tokkyo Koho, 6 pp.

CODEN: JKXXAF

	PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
PI	JP 59004087	A2	19840110	JP 1982-111672	19820630
PRAI	JP 1982-111672		19820630		

AB A InGaAsP/InP **LED** was fabricated with improved productivity and output characteristics by applying FeCl₃ etching with a resist mask so as to shape a light takeout surface into a very small **lens** when a surface **LED** in homojunction with InP or in heterojunction with InGaAs is prepared The take-out **efficiency** as well as the **connection efficiency** with optical fibers, is improved.

IC **H01L033-00**

CC 73-11 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)

ST gallium indium arsenide phosphide **LED**

IT **Electroluminescent** devices

(gallium indium arsenide phosphide-indium phosphide, with improved productivity and output characteristics)

IT Indium phosphide (InP) **22398-80-7**, properties

RL: PRP (Properties)

(**LED** from gallium indium arsenide phosphide and, with improved productivity and output characteristics)

IT Indium arsenide (InAs) **1303-00-0D**, solid solns. with indium phosphide **1303-11-3D**, solid solns. with gallium phosphide **12063-98-8D**, solid solns. with indium arsenide **22398-80-7D**, solid solns. with gallium arsenide

RL: DEV (Device component use); USES (Uses)

(**LED** from indium phosphide and, with improved productivity and output characteristics)

IT RN Indium phosphide **22398-80-7**, properties

RL: PRP (Properties)

(**LED** from gallium indium arsenide phosphide and, with improved productivity and output characteristics)

CN Indium phosphide (InP) (8CI, 9CI) (CA INDEX NAME)

IT Gallium arsenide (GaAs) **1303-00-0D**, solid solns. with indium phosphide **1303-11-3D**, solid solns. with gallium phosphide **12063-98-8D**, solid solns. with indium arsenide **22398-80-7D**, solid solns. with gallium arsenide

RL: DEV (Device component use); USES (Uses)

(**LED** from indium phosphide and, with improved productivity and output characteristics)

L27 ANSWER 19 OF 25 HCAPLUS COPYRIGHT 2004 ACS on STN
 AN 1984:42763 HCAPLUS
 TI Optical coupling in fiber optics packages with surface emitting **LED's**
 AU Berg, Howard M.; Shealy, David L.; Mitchell, Curtis M.; Stevenson, David
 W.; Lofgran, Lynn C.
 SO IEEE Transactions on Components, Hybrids, and Manufacturing Technology (1983),
 CHMT-6(3), 334-42 CODEN: ITTEDR; ISSN: 0148-6411
 AB The optical coupling performance of 2 fiber optics emitter packaging styles was
 determined into 5 large-core-diameter ($\geq 100 \mu\text{m}$) optical fibers with varying
 numerical apertures (NA). One package contains a short fiber coupled to a high
 index spherical **lens** positioned accurately between the **LED** and the fiber. The
 other package is fiberless, utilizing a high index **lens bonded** accurately to the
LED using an alignment ring technique, and projects light through the package
glass window to intercept the system fiber. Computer modeling studies were
 combined with the manufacture and anal. of actual packages to investigate the
optimum lens parameters for both packaging styles. Exptl. and modeling studies
 suggest that for optical fibers with $\text{NA} \leq 0.20$, the fiberless and short-fiber
 packages couple equivalent optical powers into fibers with diams. $\leq 200 \mu\text{m}$. For
 larger diams., the fiberless package is somewhat superior. With high NA fibers
 (≥ 0.30), however, the short-fiber package is clearly superior for fiber diams. up
 to $200 \mu\text{m}$, and equivalent for diams. $> 200 \mu\text{m}$. The excellent performance of the
 fiberless package is achieved because the alignment ring technique provides not
 only the desired alignment accuracy, but also yields a reproducible **LED -to-lens**
 spacing.

IT **Electroluminescent** devices
 (optical coupling in fiber optics packages with)

IT Gallium arsenide (GaAs) **1303-00-0**, properties
 RL: PRP (Properties)
 (**LED** from aluminum gallium arsenide and, optical coupling in
 fiber-optic packages with)

IT Gallium arsenide (GaAs) **1303-00-0D**, solid solns. with aluminum arsenide
22831-42-1D, solid solns. with gallium arsenide
 RL: DEV (Device component use); USES (Uses)
 (**LED**, optical coupling in fiber-optic packages with)

IT Gallium arsenide (GaAs) **1303-00-0**, properties
 RL: PRP (Properties)
 (**LED** from aluminum gallium arsenide and, optical coupling in
 fiber-optic packages with)

L27 ANSWER 20 OF 25 HCAPLUS COPYRIGHT 2004 ACS on STN
AN 1982:572296 HCAPLUS
TI Optical coupling in fiber optics packages with surface emitting **LED's**
AU Berg, Howard M.; Shealy, David L.; Mitchell, Curtis M.; Stevenson, David;
Quill, Michael; Lofgran, Lynn
SO Proceedings - Electronic Components Conference (1982), 32nd, 111-19
CODEN: PECCA7; ISSN: 0569-5503
AB The optical coupling performance of 2 fiber optics emitter packaging styles is determined into 5 large core diameter ($\geq 100 \mu\text{m}$) optical fibers with varying numerical apertures (NA). The short fiber FOAC package contains a high n spherical **lens** positioned accurately between the **LED** and the optical fiber internal to the package. The fiberless package utilizes a high index **lens bonded** accurately to the **LED** using an alignment ring technique, and projects light through the package's **glass** window to intercept the system fiber. Computer modeling studies are combined with the manufacture and anal. of actual packages to investigate the **optimum lens** parameters of both packaging styles. Exptl. and modeling studies suggest that for optical fibers with NA's $\leq .20$, the fiberless and short fiber packages couple equivalent optical powers into fibers with diams. $\leq 200 \mu\text{m}$. For larger diameter fibers, the fiberless package is somewhat superior. With high NA fibers ($\geq .30$), however, the short fiber package is clearly superior for fiber diams. up to $200 \mu\text{m}$, and equivalent for fiber diams. $> 200 \mu\text{m}$. The excellent performance of the fiberless package is achieved because the alignment ring technique provides not only the desired alignment accuracy, but also yields a reproducible **LED-to-lens** spacing.
IT Gallium arsenide **1303-00-0**, properties
RL: PRP (Properties)
(surface-emitting **light-emitting** diodes from aluminum gallium arsenide and, optical coupling from fiber optics packages with)
IT Aluminum arsenide **22831-42-1D**, solid solution with gallium arsenide
RL: USES (Uses)
(surface-emitting **light-emitting** diodes in gallium arsenide and, optical coupling in fiber optics packages with)
IT Gallium arsenide **1303-00-0D**, solid solns. with aluminum arsenide
RL: DEV (Device component use); USES (Uses)
(surface-emitting **light-emitting** diodes in gallium arsenide and, optical coupling in fiber optics packages with)
IT Gallium arsenide **1303-00-0**, properties
RL: PRP (Properties)
(surface-emitting **light-emitting** diodes from aluminum gallium arsenide and, optical coupling from fiber optics packages with)

L27 ANSWER 22 OF 25 HCAPLUS COPYRIGHT 2004 ACS on STN
 AN 1980:596246
 TI High-power aluminum gallium arsenide (Al_xGa_{1-x}As) heteroepitaxial emitting diodes with multimesa structure
 AU Zakgeim, A. L.; Marakhonov, V. M.; Pershina, L. P.; Seisyan, R. P.
 SO Pis'ma v Zhurnal Tekhnicheskoi Fiziki (1980), 6(17), 1034-6
 CODEN: PZTFDD; ISSN: 0320-0116
 AB High **efficiency** and high radiative power are attained in diodes with multimesa structure. In such construction, a high value of the external quantum yield is realized by means of **optimal** dimensions of each sep. mesa, which provide conditions of multipassage and internal focusing of the generated radiation. A drop in the series resistance is attained by the parallel **connection** of many mesas united in a single crystal. The overall thickness of the AlAs-GaAs epitaxial structure is increased (110-130 μm), permitting the creation of deep mesa relief with subsequent removal of the substrate. There is a photoluminescent layer which reduces the absorption on the contacts located on the tops of the mesas. The active and photoluminescent regions both contain 10 mol % AlAs. Thus narrow spectral characteristics can be attained, with maximum at 810 nm, which guarantees the possibility of use for pumping YAG:Nd³⁺ lasers. The external quantum yield in air of diodes of area 1 mm² with 25-30 sep. mesas is .apprx.10%, and the series resistance is 0.9-1.5 Ω. The use of an epoxy coating (EK-25A) with refractive index n = 1.55 increases the emitted power by a factor of 1.2, and the use of **hemispherical lenses** from chalcogenide **glass** (n = 2.2), by a factor of 2.4. A comparatively sharp drop in **efficiency** with increased current indicates the need for further reduction in the series resistance.

IT **Electroluminescent devices**
 (aluminum gallium arsenide, multimesa structure for high-power high-**efficiency**)

IT **Glass**, nonoxide
 RL: USES (Uses)
 (chalcogenide, **lenses**, in **light-emitting** diodes for improved emission)

IT Coating materials
 (epoxy, on **light-emitting** diodes for improved emission)

IT Group VIA elements
 RL: USES (Uses)
 (**glass** containing, in **lenses** for **light-emitting** diodes for improved emission)

IT **1303-00-0D**, solid solns. with aluminum arsenide
22831-42-1D, solid solns. with gallium arsenide
 RL: USES (Uses)
 (**light-emitting** diodes with multimesa structure, high-power high-**efficiency**)

IT **1303-00-0D**, solid solns. with aluminum arsenide
22831-42-1D, solid solns. with gallium arsenide
 RL: USES (Uses)
 (**light-emitting** diodes with multimesa structure, high-power high-**efficiency**)

RN 1303-00-0 HCAPLUS
 CN Gallium arsenide (GaAs) (8CI, 9CI) (CA INDEX NAME)

RN 22831-42-1 HCAPLUS
 CN Aluminum arsenide (AlAs) (6CI, 8CI, 9CI) (CA INDEX NAME)

L27 ANSWER 23 OF 25 HCAPLUS COPYRIGHT 2004 ACS on STN
AN 1980:416746 HCAPLUS
TI High-radiance aluminum gallium arsenide (AlGaAs) **LED** for
fiber-optic communications
AU Shirahata, K.; Susaki, W.; Takamiya, S.; Horiuchi, S.
SO FOC, Fiber Optics & Communications Proceedings (1978), 1st, 92-5
CODEN: PFOCD9; ISSN: 0270-3025
AB A high-radiance AlGaAs **light-emitting** diode is described which has many excellent
features for fiber-optic communications. It has a small, high-radiance **light
emitting** area and a unique practical structure with a self-aligned spherical **lens**
whose optical axis is automatically aligned with the center of the **light emitting**
area. The typical radiance of 22 W/sr/cm² for the area of 35 μ m diameter was
obtained at a low operating current of 50 mA. The micro-spherical **lens** of 100 μ m
diameter **attached** on the **light emitting** area of 35 μ m diameter makes the half-
power beam width of the radiation pattern narrow (typically 40°) and gives a
coupling **efficiency** to optical fibers as high as theor. limit. For instance, the
optical power into a fiber (core diameter : 150 μ m, NA = 0.39) is >500 μ W at 50
mA. The band width (optical power 1.5 decibel down) is typically 30 MHz, and as
high as 100 MHz at the expense of quantum **efficiency**. The band width is almost
independent of bias current. In spite of the high operating c.d. of 5 kA/cm²,
there are no remarkable changes of the optical power in the life test of 104 h at
room temperature. The lifetime >106 h was estimated from the life test at high
temps.
IT **Electroluminescent** devices
(high-radiance aluminum gallium arsenide, for fiber optic
communications)
IT Gallium arsenide (GaAs) **1303-00-0**, uses and miscellaneous
RL: USES (Uses)
(**light-emitting** diodes from aluminum gallium
arsenide double heterostructures with, for fiber optic communications)
IT Gallium arsenide (GaAs) **1303-00-0D**, solid solns. with
Aluminum arsenide (AlAs) **22831-42-1D**, solid solns. with gallium arsenide
RL: DEV (Device component use); USES (Uses)
(**light-emitting** diodes from gallium arsenide double
heterostructures with, for fiber optic communications)
IT Gallium arsenide (GaAs) **1303-00-0**, uses and miscellaneous
RL: USES (Uses)
(**light-emitting** diodes from aluminum gallium
arsenide double heterostructures with, for fiber optic communications)

L27 ANSWER 24 OF 25 HCAPLUS COPYRIGHT 2004 ACS on STN
 AN 1979:584844 HCAPLUS Full-text
 DN 91:184844
 TI Gallium indium arsenide phosphide/indium phosphide fast, high-radiance,
 1.05-1.3- μ m wavelength **LED's** with **efficient**
lens coupling to small numerical aperture silica optical fibers
 AU Goodfellow, Robert C.; Carter, Andrew C.; Griffith, Ifor; Bradley, R. R.
 CS Allen Clark Res. Cent., Plessey Res. (Caswell) Ltd.,
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 SO IEEE Transactions on Electron Devices (1979), ED-26(8), 1215-20
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 AB Power levels up to 100 μ W were launched from GaInAsP **LED's** with 14- μ m-diameter
 emitting regions into low-loss small numerical aperture (NA) silica fibers at a
 d.c. drive level of only 25 mA. A maximum launch power of 206 μ W at 100-mA d.c.
 was obtained from slightly larger devices. The high coupling **efficiency** was
 achieved using truncated spheres of Ti2O3:SiO2 **glass** as microlenses. Gains over
 the butt coupled case exceeded a factor of 12 for the small-area devices. The
 high operating current ds. (2-20 kA/cm2) for the small-area devices resulted in
 modulation bandwidths extending to beyond 300 MHz (-3 decibel optical). The
 surface-emitting **LED's** showed an enhanced performance over edge-emitting **LED's**
 fabricated from similar material. Linewidths of the devices, which were prepared
 by liquid-phase epitaxy with step followed by ramp cooling, were approx. 3 kT.
 Even with the relatively broad linewidth, material dispersion limits in silica
 fibers exceeding 1 GHz·km around 1.3 μ m are predicted. These devices are
 suitable for long-haul, wide-bandwidth fiber **links** operating in the 1.3- μ m
 window.
 IT Tin **7440-31-5**, properties 7440-66-6, properties
 RL: PRP (Properties)
 (Group IIIA metal pnictides-indium phosphide **LED** devices
 doped with)
 IT Indium phosphide (InP) **22398-80-7**, properties
 RL: PRP (Properties)
 (**LED** devices from Group IIIA metal pnictides and, with
lens coupling to silica optical fibers)
 IT Gallium arsenide (GaAs) **1303-00-0D**, solid solns. with Group IIIA metal pnictides
1303-11-3D, solid solns. with Group IIIA metal pnictides
 Indium phosphide (InP) **22398-80-7D**, solid solns. with Group IIIA metal pnictides
 RL: DEV (Device component use); USES (Uses)
 (**LED** devices from indium phosphide and, with **lens**
 coupling to silica optical fibers)
 IT Gallium phosphide (GaP) **12063-98-8D**, solid solns. with Group IIIA metal pnictides
 RL: PRP (Properties)
 (**LED** devices from indium phosphide and, with **lens**
 coupling to silica optical fibers)
 IT Gallium arsenide (GaAs) **1303-00-0D**, solid solns. with Group IIIA metal pnictides
1303-11-3D, solid solns. with Group IIIA metal pnictides
22398-80-7D, solid solns. with Group IIIA metal pnictides
 RL: DEV (Device component use); USES (Uses)
 (**LED** devices from indium phosphide and, with **lens**
 coupling to silica optical fibers)